

Notice of References Cited

 Application/Control No.
 10/003,363

 Applicant(s)/Patent Under
 Reexamination
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0028357	03-2002	Shukh et al.	428/694.0TM
	B	US-4,687,712	08-1987	Sugita et al.	428/611
	C	US-6,468,670	10-2002	Ikeda et al.	428/611
	D	US-2001/0009730	07-2001	FUTAMOTO et al.	428/694.0TM
	E	US-5,759,681	06-1998	Hosoe et al.	428/332
	F	US-5,466,308	11-1995	Fujimura et al.	148/302
	G	US-2001/0019786	09-2001	Ikeda, Hiroyuki	428/694.0TM
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP-303324-A1	02-1989	EP	Brouha et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kraus, L, Haslar, V., and Duhaj, P. (IEEE Trans. Mag., 30(2), 1994, 530 - 532).
	V	Beatrice, C., Pasquaule, M., and Bertotti, G. (IEEE Trans. Mag. 33(5), 1997, 3772 - 3774).
	W	Platt, C., Minor, M., and Klemmer, T. (IEEE Trans. Mag., 37(4), 2001, 2302 - 2304).
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.